

ZXMC3F31DN8 **30V SO8 Complementary dual enhancement mode** **MOSFET**

Summary

Device	$V_{(BR)DSS}$ (V)	Q_G (nC)	$R_{DS(on)}$ (Ω)	I_D (A)
Q1	30	12.9	0.024 @ $V_{GS} = 10V$	7.3
			0.039 @ $V_{GS} = 4.5V$	5.7
Q2	-30	12.7	0.045 @ $V_{GS} = -10V$	5.3
			0.080 @ $V_{GS} = -4.5V$	4



Description

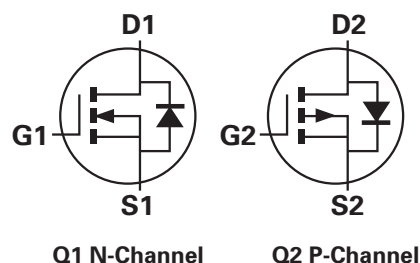
This new generation Trench MOSFET from Zetex has been designed to minimize the on-state resistance ($R_{DS(on)}$) and yet maintain superior switching performance making it ideal for power management and battery charging functions.

Features

- Low on-resistance
- 4.5V gate drive capability
- Low profile SOIC package

Applications

- DC-DC Converters
- SMPS
- Load switching switches
- Motor control
- Backlighting

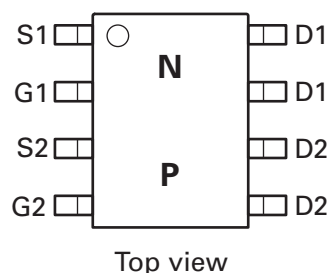


Ordering information

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMC3F31DN8TA	7	12	500

Device marking

ZXMC
3F31



ZXMC3F31DN8

Absolute maximum ratings

Parameter	Symbol	N-channel Q1	P-channel Q2	Unit
Drain-Source voltage	V_{DSS}	30	-30	V
Gate-Source voltage	V_{GS}	± 20	± 20	V
Continuous Drain current @ $V_{GS}=10V$; $T_A=25^\circ C$ (b)(d) @ $V_{GS}=10V$; $T_A=70^\circ C$ (b)(d) @ $V_{GS}=10V$; $T_A=25^\circ C$ (a)(d) @ $V_{GS}=10V$; $T_A=25^\circ C$ (a)(e) @ $V_{GS}=10V$; $T_L=25^\circ C$ (f)(d)	I_D	7.3 5.9 5.7 6.8 7.8	5.3 4.3 4.1 4.9 5.7	A
Pulsed Drain current (c)	I_{DM}	33	23	A
Continuous Source current (Body diode) (b)(d)	I_S	3.5	3.2	A
Pulsed Source current (Body diode) (c)(d)	I_{SM}	33	23	A
Power dissipation at $T_A=25^\circ C$ (a)(d) Linear derating factor	P_D	1.25 10		W mW/ $^\circ C$
Power dissipation at $T_A=25^\circ C$ (a)(e) Linear derating factor	P_D	1.8 14		W mW/ $^\circ C$
Power dissipation at $T_A=25^\circ C$ (b)(d) Linear derating factor	P_D	2.1 17		W mW/ $^\circ C$
Power dissipation at $T_L=25^\circ C$ (f) (d) Linear derating factor	P_D	2.35 19		W mW/ $^\circ C$
Operating and storage temperature range	T_j, T_{stg}	-55 to 150		$^\circ C$

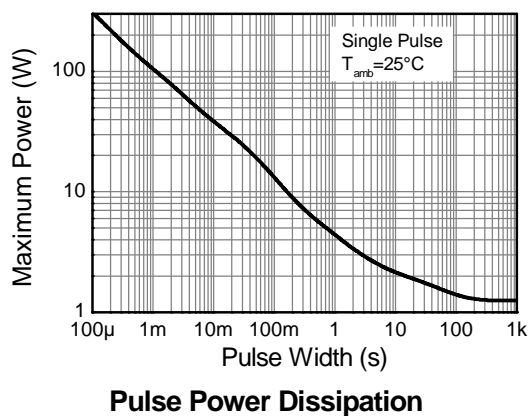
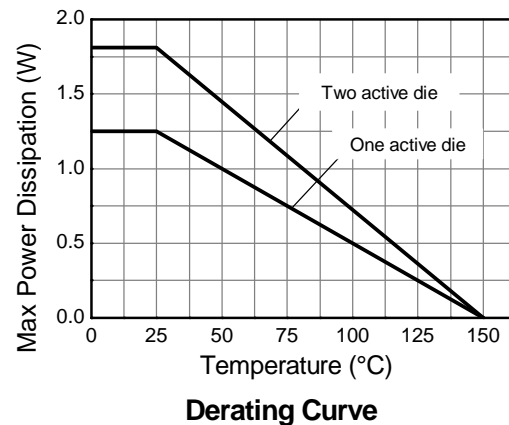
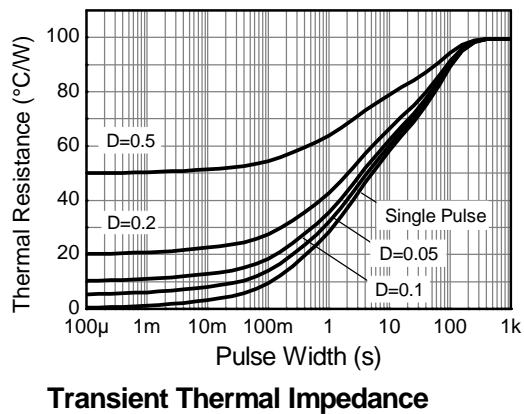
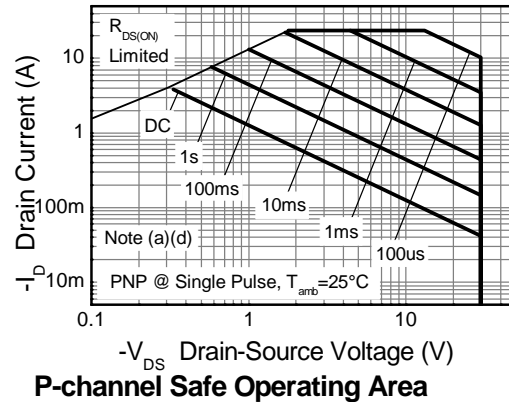
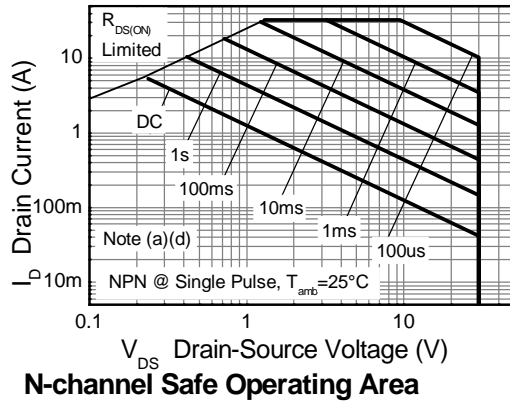
Thermal resistance

Parameter	Symbol	Value	Unit
Junction to ambient (a)(d)	$R_{\theta JA}$	100	$^\circ C/W$
Junction to ambient (a)(e)	$R_{\theta JA}$	70	$^\circ C/W$
Junction to ambient (b)(d)	$R_{\theta JA}$	60	$^\circ C/W$
Junction to lead (f) (d)	$R_{\theta JL}$	53	$^\circ C/W$

NOTES:

- (a) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.
- (b) Mounted on FR4 PCB measured at $t \leq 10$ sec.
- (c) Repetitive rating on 25mm x 25mm FR4 PCB, $D=0.02$, pulse width 300us – pulse width limited by maximum junction temperature.
- (d) For a device with one active die.
- (e) For a device with two active die running at equal power.
- (f) Thermal resistance from junction to solder-point (at the end of the drain lead).

Thermal characteristics



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Q1 N-channel electrical characteristics (at $T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	$V_{(BR)DSS}$	30			V	$I_D = 250\mu A, V_{GS}=0V$
Zero Gate voltage Drain current	I_{DSS}			0.5	μA	$V_{DS}=30V, V_{GS}=0V$
Gate-Body leakage	I_{GSS}			100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Gate-Source threshold voltage	$V_{GS(th)}$	1.0		3.0	V	$I_D = 250\mu A, V_{DS}=V_{GS}$
Static Drain-Source on-state resistance (*)	$R_{DS(on)}$			0.024 0.039	Ω	$V_{GS}= 10V, I_D= 7.0A$ $V_{GS}= 4.5, I_D= 6.0A$
Forward Transconductance (*) (†)	g_{fs}		16.5		S	$V_{DS}= 15V, I_D= 7.0A$
Dynamic (†)						
Input capacitance	C_{iss}		608		pF	$V_{DS}= 15V, V_{GS}=0V$ $f=1MHz$
Output capacitance	C_{oss}		132		pF	
Reverse transfer capacitance	C_{rss}		72		pF	
Switching (‡) (†)						
Turn-on-delay time	$t_{d(on)}$		2.9		ns	$V_{DD}= 15V, V_{GS}=10V$ $I_D= 1A$ $R_G \cong 6.0\Omega,$
Rise time	t_r		3.3		ns	
Turn-off delay time	$t_{d(off)}$		16		ns	
Fall time	t_f		8		ns	
Total Gate charge	Q_g		12.9		nC	$V_{DS}= 15V, V_{GS}= 10V$ $I_D= 7A$
Gate-Source charge	Q_{gs}		2.5		nC	
Gate-Drain charge	Q_{gd}		2.52		nC	
Source-Drain diode						
Diode forward voltage (*)	V_{SD}		0.82	1.2	V	$I_S= 1.7A, V_{GS}=0V$
Reverse recovery time (‡)	t_{rr}		12		ns	$I_S= 2.2A, di/dt=100A/\mu s$
Reverse recovery charge (‡)	Q_{rr}		4.8		nC	

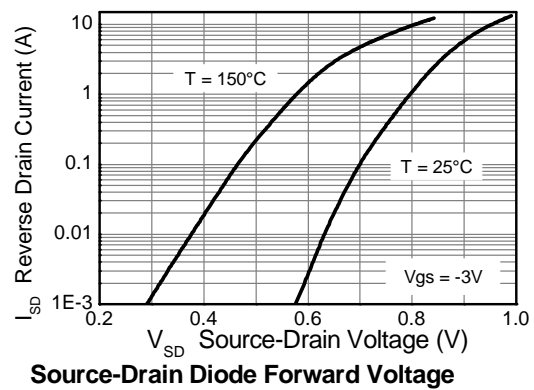
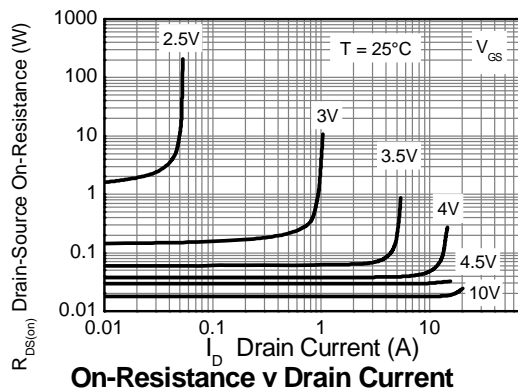
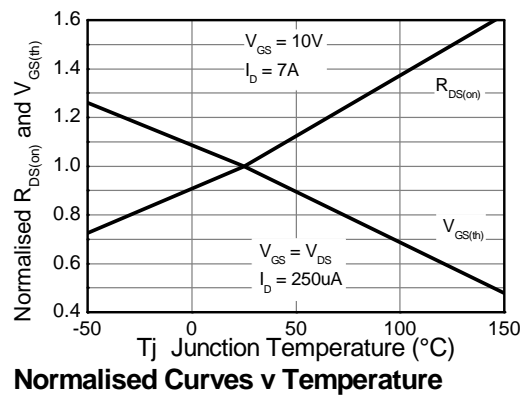
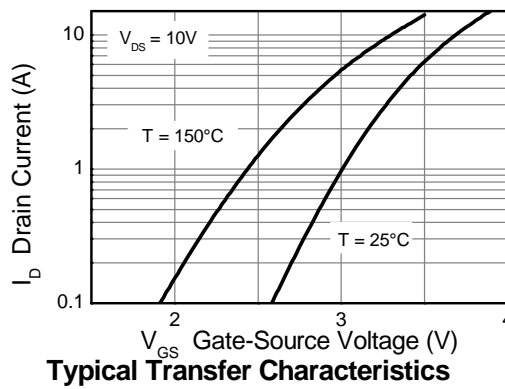
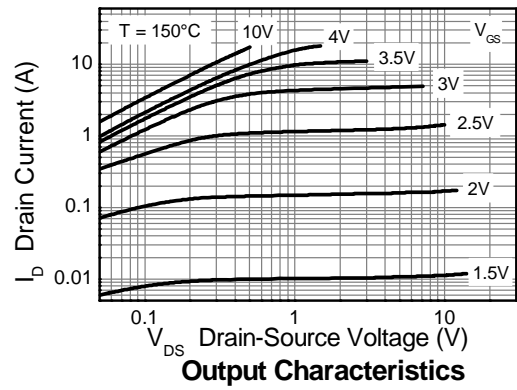
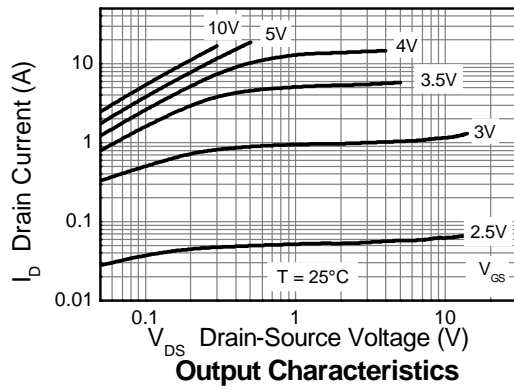
NOTES:

(*) Measured under pulsed conditions. Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

(†) Switching characteristics are independent of operating junction temperature.

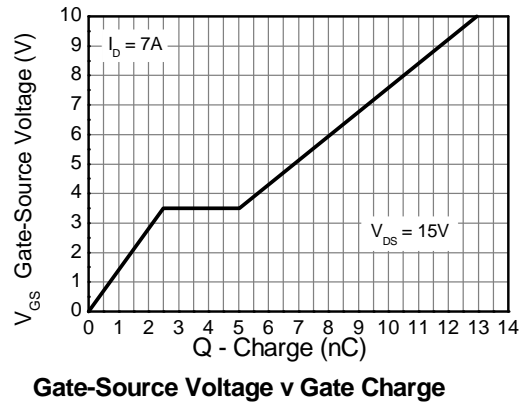
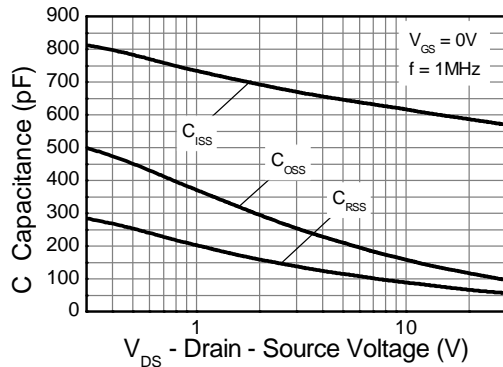
(‡) For design aid only, not subject to production testing

Q1 Typical characteristics

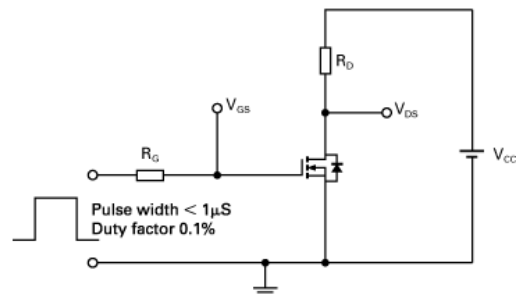
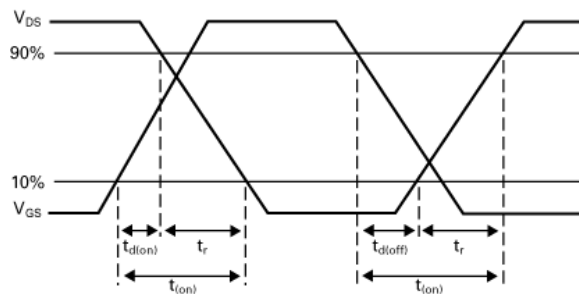
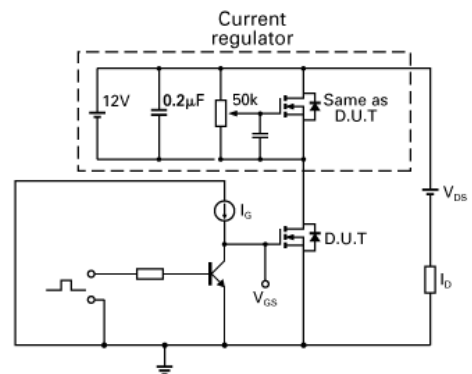
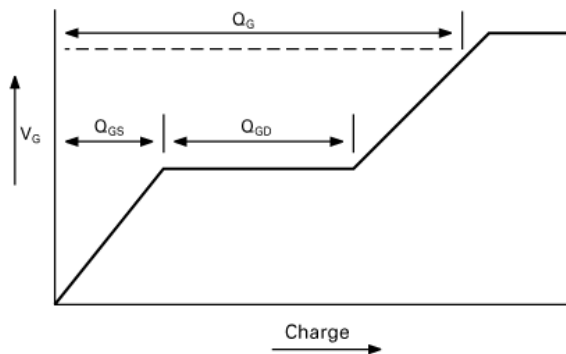


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Q1 Typical characteristics –cntd.



Test circuits



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Q2 P-channel electrical characteristics (at $T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	$V_{(BR)DSS}$	-30			V	$I_D = -250\mu A, V_{GS}=0V$
Zero Gate voltage Drain current	I_{DSS}			-5.0	μA	$V_{DS}=-30V, V_{GS}=0V$
Gate-Body leakage	I_{GSS}			-100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Gate-Source threshold voltage	$V_{GS(th)}$	-1.0		-3.0	V	$I_D= -250\mu A, V_{DS}=V_{GS}$
Static Drain-Source on-state resistance ^(*)	$R_{DS(on)}$			0.045 0.080	Ω	$V_{GS}= -10V, I_D= -5.0A$ $V_{GS}= -4.5V, I_D= -4.0A$
Forward Transconductance ^(*) (†)	g_{fs}		14		S	$V_{DS}= -15V, I_D= -5.0A$
Dynamic ^(†)						
Input capacitance	C_{iss}		670		pF	$V_{DS}= -15V, V_{GS}=0V$ $f=1MHz$
Output capacitance	C_{oss}		126		pF	
Reverse transfer capacitance	C_{rss}		70		pF	
Switching ^(‡) (†)						
Turn-on-delay time	$t_{d(on)}$		1.9		ns	$V_{DD}= -15V, V_{GS}=-10V$ $I_D= -1A$ $R_G \cong 6.0\Omega,$
Rise time	t_r		3		ns	
Turn-off delay time	$t_{d(off)}$		30		ns	
Fall time	t_f		21		ns	
Total Gate charge	Q_g		12.7		nC	$V_{DS}= -15V, V_{GS}= -10V$ $I_D= -5A$
Gate-Source charge	Q_{gs}		2		nC	
Gate-Drain charge	Q_{gd}		2.4		nC	
Source-Drain diode						
Diode forward voltage ^(*)	V_{SD}		-0.82	-1.2	V	$I_S= -2A, V_{GS}=0V$
Reverse recovery time ^(‡)	t_{rr}		16.5		ns	$I_S= -2.1A, di/dt=100A/\mu s$
Reverse recovery charge ^(‡)	Q_{rr}		11.5		nC	

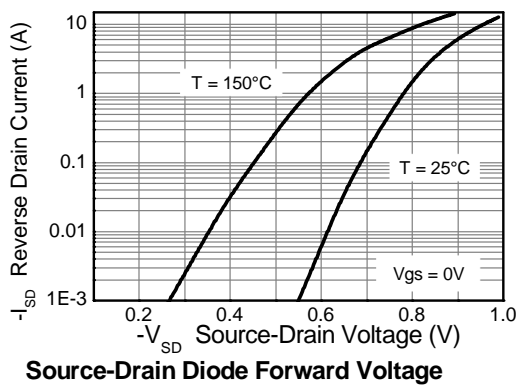
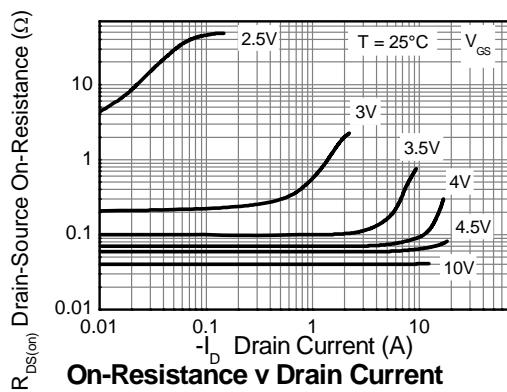
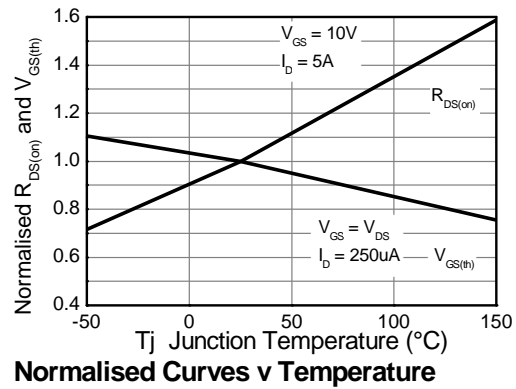
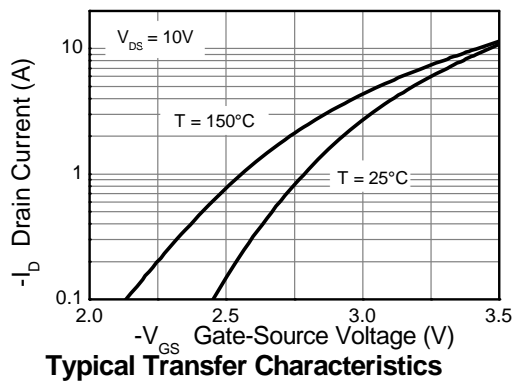
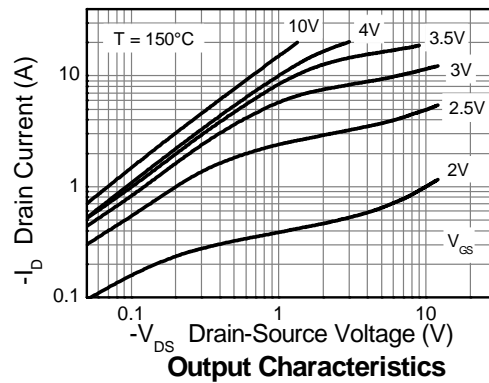
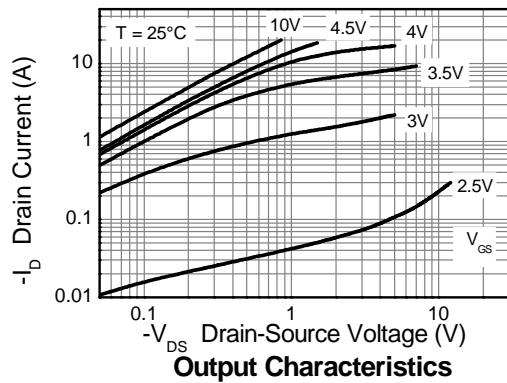
NOTES:

(*) Measured under pulsed conditions. Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

(†) Switching characteristics are independent of operating junction temperature.

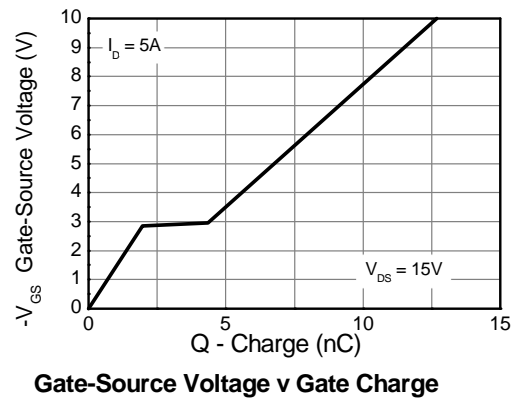
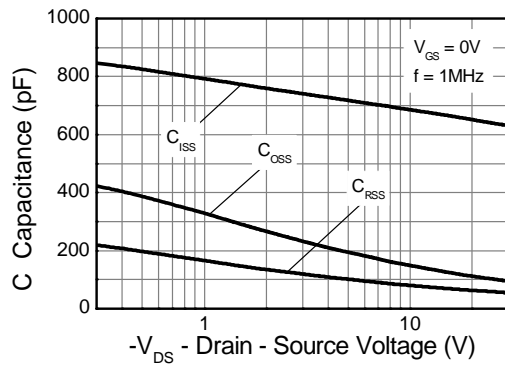
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Typical characteristics

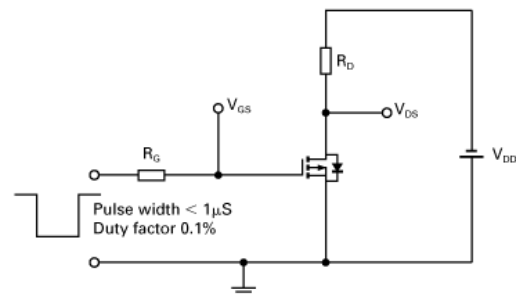
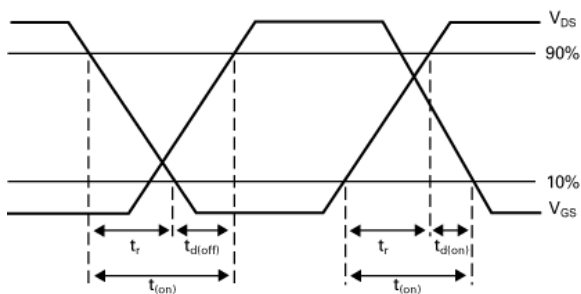
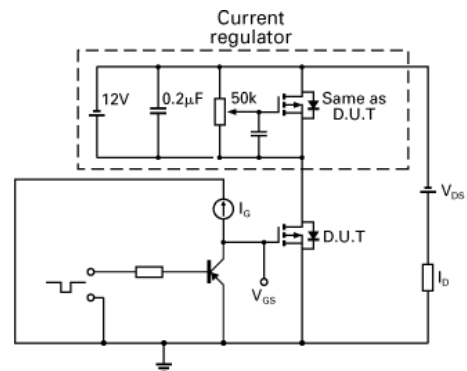
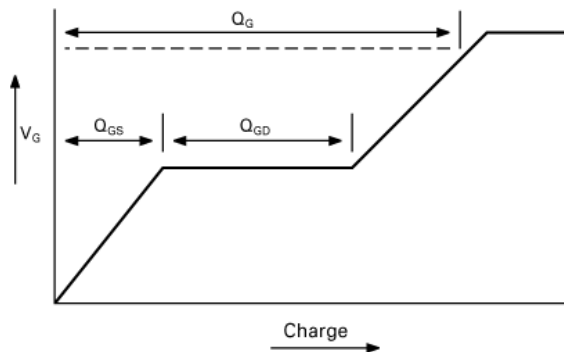


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Typical characteristics

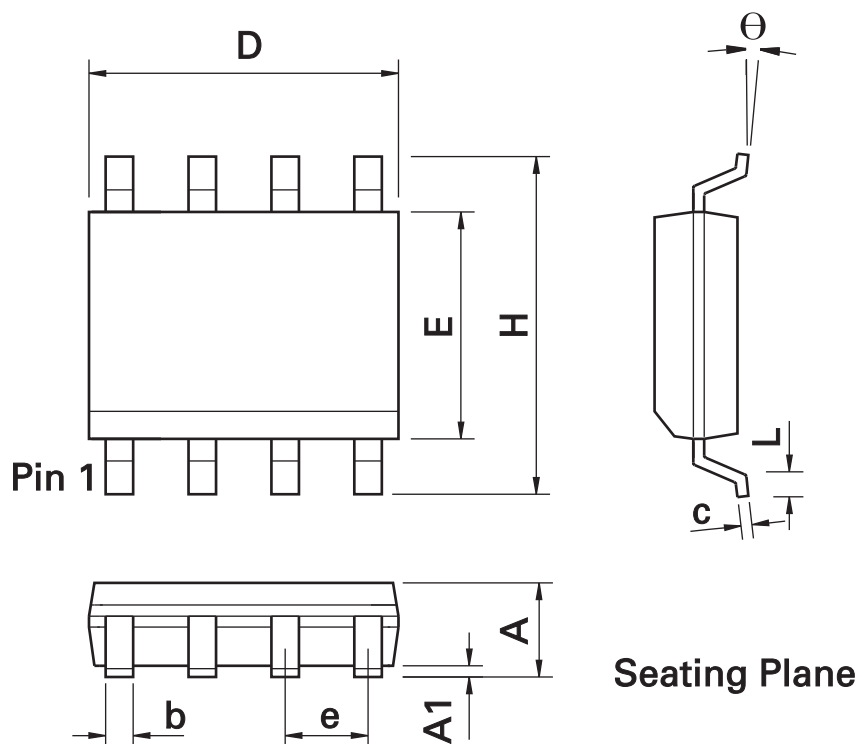


Test circuits



ZXMC3F31DN8

Package outline SO8



SO8 Package Information

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.053	0.069	1.35	1.75	e	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	c	0.008	0.010	0.19	0.25
H	0.228	0.244	5.80	6.20	U	0°	8°	0°	8°
E	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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